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AIRCHI FDP6030L/FDB6030L N-Channel Logic Level PowerTrench<sup>®</sup> MOSFET **General Description** Features This N-Channel Logic Level MOSFET has been • 48 A, 30 V  $R_{DS(ON)}$  = 13 m $\Omega$  @ V<sub>GS</sub> = 10 V designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers.

These MOSFETs feature faster switching and lower gate charge than other MOSFETs with comparable R<sub>DS(ON)</sub> specifications.

The result is a MOSFET that is easy and safer to drive (even at very high frequencies), and DC/DC power supply designs with higher overall efficiency.

It has been optimized for low gate charge, low R<sub>DS(ON)</sub> and fast switching speed.

- $R_{DS(ON)} = 17 \text{ m}\Omega @ V_{GS} = 4.5 \text{ V}$
- Critical DC electrical parameters specified at elevated temperature
- High performance trench technology for extremely low R<sub>DS(ON)</sub>

D

175°C maximum junction temperature rating



### Absolute Maximum Ratings T<sub>A</sub>=25°C unless otherwise noted

Symbol	Parameter	Ratings	Units
V <sub>DSS</sub>	Drain-Source Voltage	30	V
V <sub>GSS</sub>	Gate-Source Voltage	± 20	V
ID	Drain Current – Continuous (Note 1)	48	А
	– Pulsed	150	
PD	Total Power Dissipation @ T <sub>c</sub> = 25°C	52	W
	Derate above 25°C	0.3	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range	-65 to +175	°C

D

$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	2.9	°C/W	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62.5		

# Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
FDB6030L	FDB6030L	13"	24mm	800 units
FDP6030L	FDP6030L	Tube	n/a	45

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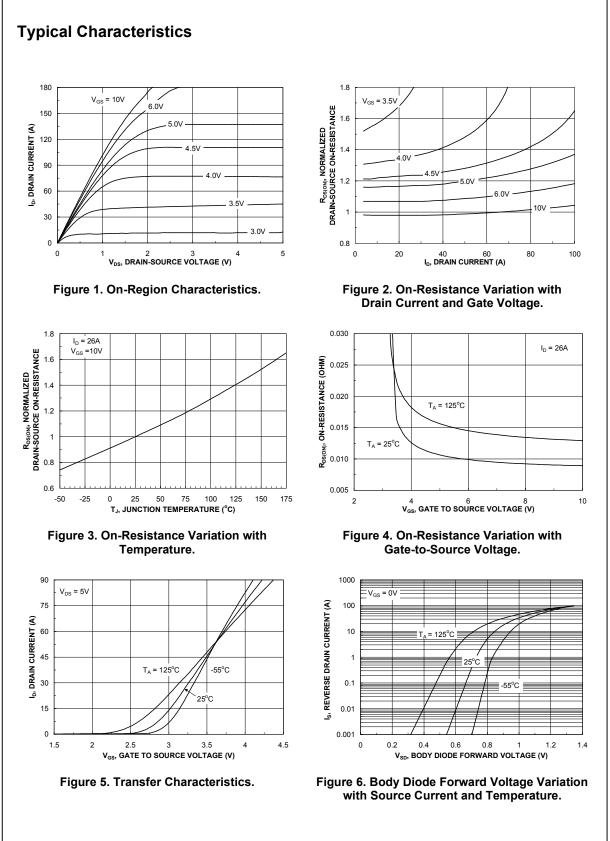


Symbol	Parameter	Test Conditions	Min	Тур	Мах	Units
-	Durce Avalanche Ratings (Note					
E <sub>AS</sub>	Single Pulse Drain-Source	$V_{DD} = 15 V, I_D = 26 A$			100	mJ
-43	Avalanche Energy					
I <sub>AS</sub>	Maximum Drain-Source Avalanche Current				26	A
Off Char	acteristics					
BV <sub>DSS</sub>	Drain–Source Breakdown Voltage	$V_{GS} = 0 V$ , $I_{D} = 250 \mu A$	30			V
<u>ΔBVdss</u> ΔTj	Breakdown Voltage Temperature Coefficient	$I_D$ = 250 $\mu$ A, Referenced to 25°C		23		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 24 V$ , $V_{GS} = 0 V$			1	μA
I <sub>GSS</sub>	Gate–Body Leakage	$V_{GS}$ = ± 20 V, $V_{DS}$ = 0 V			± 100	nA
On Char	acteristics (Note 2)					
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}$ , $I_D = 250 \ \mu A$	1	1.9	3	V
$\Delta V_{GS(th)} \Delta T_J$	Gate Threshold Voltage Temperature Coefficient	$I_D$ = 250 $\mu$ A, Referenced to 25°C		-5		mV/°C
R <sub>DS(on)</sub>	Static Drain–Source On– Resistance			7.9 10.2 13.0	13 17 20	mΩ
I <sub>D(on)</sub>	On–State Drain Current	$V_{GS} = 10 \text{ V},  V_{DS} = 10 \text{ V}$	60			Α
g <sub>FS</sub>	Forward Transconductance	$V_{DS} = 10V, I_D = 26 A$		68		S
	c Characteristics					
C <sub>iss</sub>	Input Capacitance	$V_{DS} = 15 V$ , $V_{GS} = 0 V$ ,		1250		pF
Coss	Output Capacitance	f = 1.0  MHz		330		pF
	Reverse Transfer Capacitance	_		155		<u>'</u>
C <sub>rss</sub> R <sub>G</sub>	Gate Resistance	V <sub>GS</sub> = 15 mV, f = 1.0 MHz		1.3		pF Ω
-		$V_{GS} = 15 11V, 1 = 1.0 10112$		1.5		52
	Turn–On Delay Time		1	11	20	
t <sub>d(on)</sub> t <sub>r</sub>	Turn–On Delay Time	$V_{DD}$ = 15V, $I_D$ = 1 A, $V_{GS}$ = 10 V, $R_{GEN}$ = 6 Ω		12	20	ns ns
	Turn–Off Delay Time	_		29	46	ns
t <sub>d(off)</sub> t <sub>f</sub>	Turn-Off Fall Time	-		12	21	ns
q Qg	Total Gate Charge	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 26 A,		13	18	nC
Q <sub>gs</sub>	Gate-Source Charge	$V_{GS} = 5 V$		3.9	10	nC
Q <sub>gd</sub>	Gate-Drain Charge	-		5.2		nC
	5	and Maximum Datings		0.2		
Drain-5	ource Diode Characteristics				48	A
V <sub>SD</sub>	Drain–Source Diode Forward Voltage	$V_{GS} = 0 V$ , $I_S = 26 A$ (Note 1)		0.92	1.3	V
t <sub>rr</sub>	Diode Reverse Recovery Time	I <sub>F</sub> = 26 A,		26		nS
Q <sub>rr</sub>	Diode Reverse Recovery Charge	$d_{iF}/d_t = 100 \text{ A}/\mu\text{s}$		15		nC

1. Calculated continuous current based on maximum allowable junction temperature.

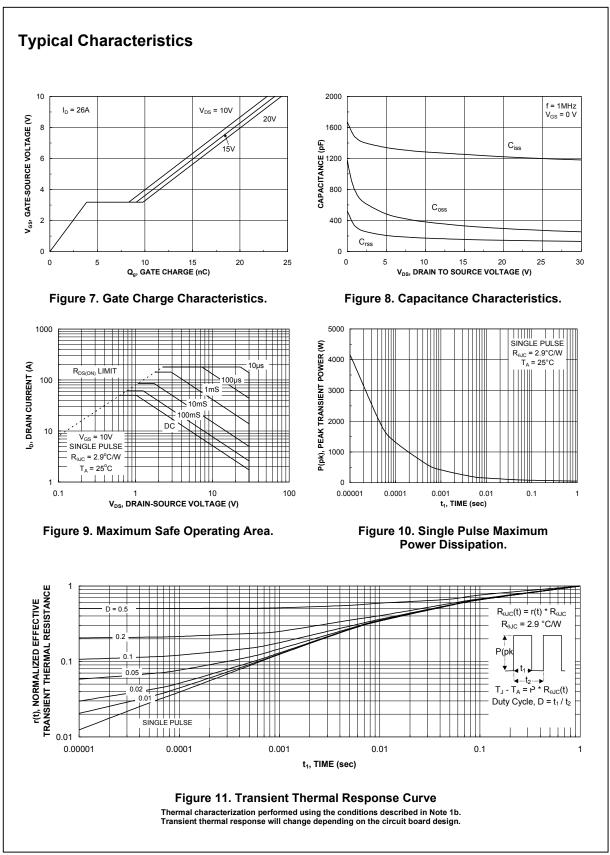
2. Pulse Test: Pulse Width < 300µs, Duty Cycle < 2.0%

# FDP6030L/FDB6030L



FDP6030L/FDB6030L

FDP6030L/FDB6030L Rev E(W)



FDP6030L/FDB6030L

FDP6030L/FDB6030L Rev E(W)

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E <sup>2</sup> CM EnSig FACT Acros The P	gna™ ™ ss the board Power Franc		MSXPro™ OCX™ OCXPro™ OPTOLOGIC <sup>®</sup> OPTOPLANAR™ PACMAN™ DODIM	Quiet Series <sup>™</sup> RapidConfigure <sup>™</sup> RapidConnect <sup>™</sup> SILENT SWITCHER <sup>®</sup> SMART START <sup>™</sup> SPM <sup>™</sup> Stealth <sup>™</sup> SuperSOT <sup>™</sup> 2	UHC™ UltraFET <sup>®</sup> VCX™
The Power Franchise™ Programmable Active Droop™		POP™	SuperSOT™-3		

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